

Specification

Drawing No.	UKY1C-H1-18412-00[43] 1/10
Issued Date.	Jun.4,2018

TO: Digi-Key

Note: In case of specification change, KYOCERA Part Number also will be changed.

Product Name	Quartz Crystal
Product Model	CX3225CA
Frequency	12000kHz
Customer Part Number	-
Customer Specification Number	-
KYOCERA Part Number	CX3225CA12000D0KPSC1
Remarks	RoHS Compliant, MSL 1 AEC-Q200 Compliant

Customer Acceptance

Accept Signature	Approved Date	
	Department	
	Person in charge	

Seller

KYOCERA Corporation

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Electronic Components Sales Division
6 Takeda Tobadono-cho, Fushimi-ku, Kyoto
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Manufacturer

Corporate Electronic Components Group
Crystal Components Division

Design Department	Quality Assurance	Approved by	Examination by	Issued by
KYOCERA Corporation Crystal Units Design Engineering Yamagata Section Crystal Product Division	W.Muraoka	Y.Takahashi	A.Ito	Y. Kikuchi

Revision History

Rev.No.	Description of revise	Date	Approved by	Examination by	Issued by
1	First Edition	Jun.4,2018	Y.Takahashi	A.Ito	Y. Kikuchi

1. APPLICATION

This specification sheet is applied to quartz crystal “CX3225CA12000D0KPSC1”

2. KYOCERA PART NUMBER

CX3225CA12000D0KPSC1

3. RATINGS

Items	SYMB.	Rating	Unit	Remarks
Operating Temperature	Topr	-40 to +85	°C	
Storage Temperature Range	Tstg	-40 to +150	°C	

4. CHARACTERISTICS

ELECTRICAL CHARACTERISTICS

Items	Electrical Specification					Test Condition	Remarks
	SYMB.	Min.	Typ.	Max.	Unit		
Mode of Vibration		Fundamental					
Nominal Frequency	F0		12		MHz		
Nominal Temperature	T _{NOM}		+25		°C		
Load Capacitance	CL	8.0			pF		
Frequency Tolerance	df/F	-30.0		+30.0	PPM	+25±3°C	
Frequency Temperature Characteristics	df/F	-50.0		+50.0		-40 to +85°C	
Frequency Aging Rate		-5.0		+5.0		1 st year	+25±3°C
Equivalent Series Resistance	ESR			200	Ω		
Drive Level	Pd	0.01		200	μW		
Insulation Resistance	IR	500			MΩ	100V(DC)	

5. Measurement Condition

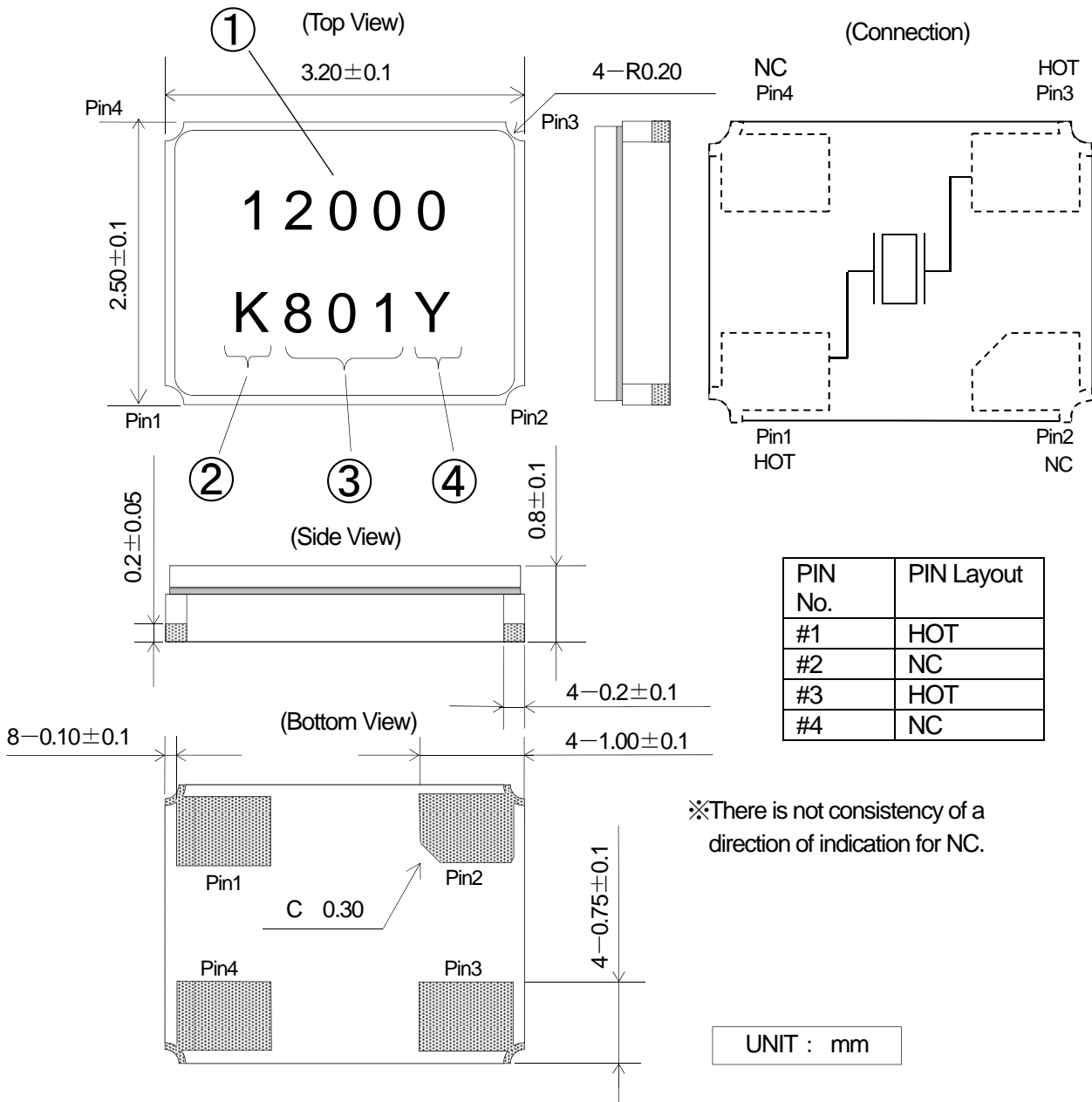
5.1 Frequency measurement

Measuring instrument : IEC PI-Network Test Fixture
Load Capacitance : 8.0pF
Drive Level : 10 μ W

5.2 Equivalent series resistance (ESR) measurement

Measuring instrument : IEC PI-Network Test Fixture
Load Capacitance : Series
Drive Level : 10 μ W

6. APPEARANCES, PHYSICAL DIMENSION
OUTLINE DIMENSION (not to scale)



MARKING

1 Nominal Frequency

Move the number of maximum indication beams of the frequency to five digits, and omit less than kHz.

2 Identification

3 Date Code

Year ···LAST 1 DIGIT of YEAR AND WEEK

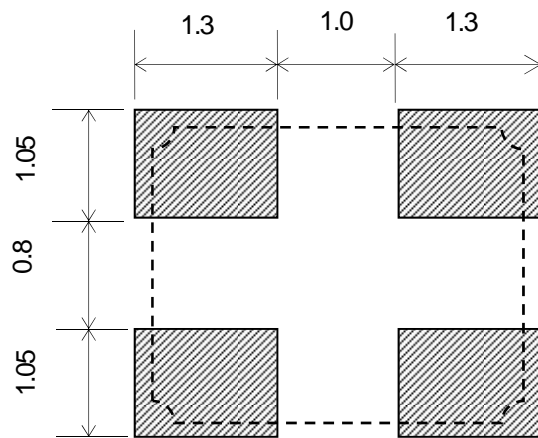
(Ex) Jan. 1, 2018 → 801

4 Manufacturing Location

Y···Japan(Yamagata)

※The font of marking is reference.

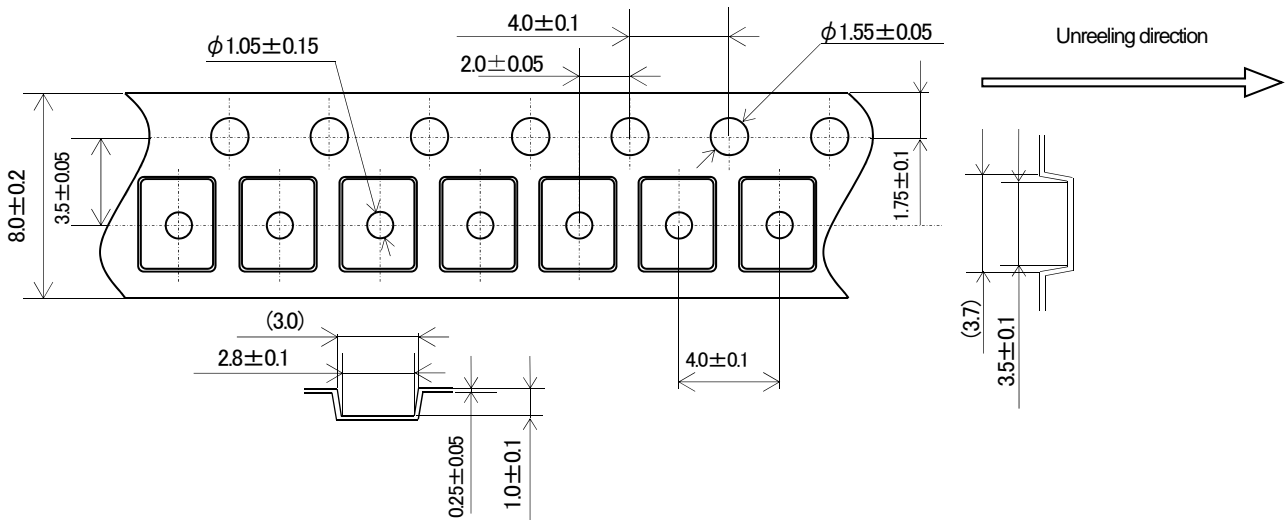
7. RECOMMENDED LAND PATTERN (not to scale)



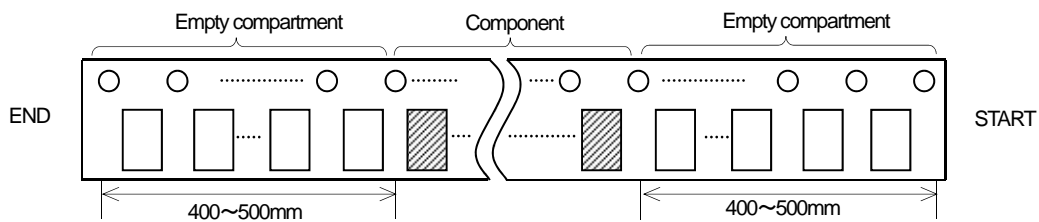
UNIT : mm

8.TAPING & REEL

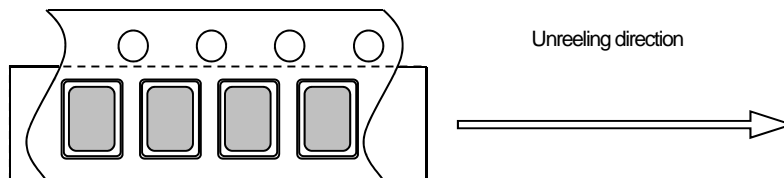
8-1.Dimensions



8-2.Leader and trailer tape

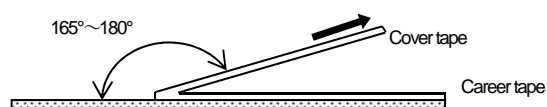


8-3.Direction (The direction shall be seen from the top cover tape side)

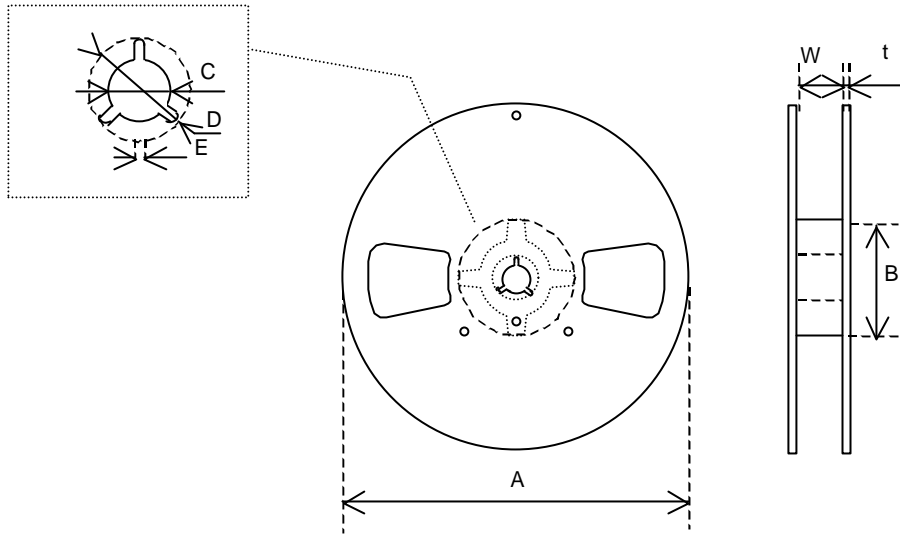


8-4.Specification

1. Material of the carrier tape is either polystyrene or A-PET (ESD).
2. Material of the cover tape is polyester (ESD).
3. The seal tape shall not cover the sprocket holes and not protrude from the carrier tape.
4. Tensile strength of carrier tape: 10N or more.
5. The R of the corner of each cavity is $0.2R_{MAX}$.
6. The alignment between centers of the cavity and sprocket hole shall be 0.05mm or less.
7. Peeling force of cover tape: 0.1 to 1.0N.
8. The component will fall out naturally when cover tape is removed and set upside down.
9. The marking on parts is not fixed its direction, its electrical characteristic is equal.



8-5.Reel specifications



(Nonconductor type Reel)

Φ180 Reel (3000pcs max.)

	A	B	C	D
Dimension	$\varphi 180 +0/-1.5$	$\varphi 60 +1/-0$	$\varphi 13 \pm 0.2$	$\varphi 21 \pm 0.8$
Symbol	E	W	t	
Dimension	2.0 ± 0.5	9 ± 1	2.0 ± 0.5	

(Unit : mm)

9.Environmental requirements

(Reference: AEC-Q200 Rev. D. The solder used by examination is hereafter set to Sn-3Ag-0.5Cu.)

After following test, Frequency applies to each item and CI, $\pm 20\%$ or 5Ω of large value.

No	Stress	Reference	Additional Requirements
9.1	High Temperature Exposure (Storage)	MIL-STD-202 Method 108	1000 hrs. at rated operating temperature (e.g. 85°C part can be stored for 1000 hrs at 85°C. Same applies for 125°C). Unpowered. Measurement at 24 \pm 4 hours after test conclusion.
9.2	Temperature Cycling	JESD22 Method JA-104	1000 cycles (-40°C to 125°C) Note: If 85°C part the 1000 cycles will be at that temperature rating. Measurement at 24 \pm 4 hours after test conclusion. 30min maximum dwell time at each temperature extreme. 1 min. maximum transition time.
9.3	Biased Humidity	MIL-STD- 202 Method 103	1000 hours 85°C/85%RH. Rated VDD applied with 1 MW and inverter in parallel, 2X crystal CL capacitors between each crystal leg and GND. Measurement at 24 \pm 4 hours after test conclusion.
9.4	Operational Life	MIL-STD- 202 Method 108	Note: 1000 hrs @ 125°C. If 85°C part will be tested at that temperature. Rated VDD applied with 1 MW and inverter in parallel, 2X crystal CL capacitors between each crystal leg and GND. Measurement at 24 \pm 4 hours after test conclusion.
9.5	Terminal Strength (Leaded)	MIL-STD- 202 Method 211	Test leaded device lead integrity only. Conditions: A (227 g), C (227 g).
9.6	Resistance to Solvents	MIL-STD- 202 Method 215	Note: Also aqueous wash chemical - OKEM clean or equivalent. Do not use banned solvents.
9.7	Mechanical Shock	MIL-STD-202 Method 213	Figure 1 of Method 213. Condition C
9.8	Vibration	MIL-STD-202 Method 204	5g's for 20 minutes 12 cycles each of 3 orientations. Note: Use 8"X5" PCB .031" thick with 7 secure points on one 8" side and 2 secure points on corners of opposite sides. Parts mounted within 2" from any secure point. Test from 10-2000 Hz.
9.9	Resistance to Soldering Heat	MIL-STD-202 Method 210	Condition B No pre-heat of samples. Note: Single Wave solder - Procedure 1 with solder within 1.5 mm of device body for Leaded. Procedure 1 except 230°C and immerse only to level to cover terminals for SMD.
9.10	Solder ability	J-STD-002	For both Leaded & SMD. Electrical Test not required. Magnification 50 X. Conditions: Leaded: Method A @ 235°C, category 3. SMD: a) Method B, 4 hrs @ 155°C dry heat @ 235°C b) Method B @ 215°C category 3. c) Method D category 3 @ 260°C.
9.11	Flammability	UL-94	V-0 or V-1 Acceptable
9.12	Board Flex	AEC Q200-005	60 sec minimum holding time.
9.13	Terminal Strength(SMD)	AEC Q200-006	-

10. Cautions for use

(1) Soldering upon mounting

There is a possibility to influence product characteristics when Solder paste or conductive glue comes in contact with product lid or surface.

(2) When using mounting machine

Please minimize the shock when using mounting machine to avoid any excess stress to the product.

(3) Conformity of a circuit

We strongly recommend to make sure that Negative resistance (Gain) of IC is designed to be 10 times the ESR (Equivalent Series Resistance) of crystal unit.

(4) After making the Quartz Crystal mount on a printed circuit board ,if it is required to divide the printed circuit board into another one, use it with attentive confirmation so that a warp caused by this dividing might not affect any damage. When designing a printed circuit board as well as handling the mounting As much as possible. The quartz crystal shall be passed through the reflow furnace. Then it shall be subjected to standard atmospheric conditions, after which cleaning shall be made.

11. Storage conditions

Please store product in below conditions, and use within 6 months.

Temperature +18 to +30°C, and Humidity of 20 to 70 % in the packaging condition.

12. Manufacturing location

Kyocera Corporation Yamagata Higashine plant / Japan(Yamagata)

13. Quality Assurance

To be guaranteed by Kyocera Corporation Yamagata Higashine plant Quality Assurance Division

14. Quality guarantee

In case when Kyocera Corporation rooted failure occurred within 1year after its delivery, substitute product will be arranged based on discussion. Quality guarantee of product after 1year of its delivery is waived.

15. Others

In case of any questions or opinions regarding the Specification, please have it in written manner within 45 days after issued date.